## Application/Control No. 10/038,529 Applicant(s)/Patent Under Reexamination JAYACHANDRA, MAHESH Examiner Fritz Alphonse Art Unit Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,457,454	10-1995	Sugano, Jin	341/22
	В	US-5,880,685	03-1999	Weeks, James A.	341/22
	С	US-6,631,501	10-2003	Jurion et al.	715/535
	D	US-2003/0119551	06-2003	Laukkanen et al.	455/556
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			-
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	σ					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
	U			
	٧			
	w			
	х			

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.